

lys_instr: A Python Package for Automating Scientific Measurements

Ziqian Wang  ^{1,2}¶, Hidenori Tsuji², Toshiya Shiratori  ³, and Asuka Nakamura  ^{2,3}

¹ Research Institute for Quantum and Chemical Innovation, Institutes of Innovation for Future Society, Nagoya University, Japan  ² RIKEN Center for Emergent Matter Science, Japan  ³ Department of Applied Physics, The University of Tokyo, Japan  ¶ Corresponding author

DOI: [10.xxxxxx/draft](https://doi.org/10.xxxxxx/draft)

Software

- [Review](#) ↗
- [Repository](#) ↗
- [Archive](#) ↗

Editor: [Open Journals](#) ↗

Reviewers:

- [@openjournals](#)

Submitted: 01 January 1970

Published: unpublished

License

Authors of papers retain copyright and release the work under a ¹⁹ Creative Commons Attribution 4.0 International License ([CC BY 4.0](#))²⁰

Summary

Modern experiments increasingly demand automation frameworks that coordinate diverse scientific instruments while remaining flexible and customizable. Existing solutions, however, often require explicit management of low-level communication and concurrency, resulting in substantial development overhead. We present lys_instr, a Python package that addresses these challenges through an object-oriented, multi-layered architecture for instrument control, workflow coordination, and GUI construction. It enables researchers to rapidly build responsive, asynchronous measurement systems with minimal coding effort. Seamlessly integrated with the lys platform ([Nakamura, 2023](#)), lys_instr unifies experiment control, data acquisition, and visualization, providing an efficient foundation for next-generation automation-driven experimental research.

Statement of need

Modern scientific research increasingly relies on comprehensive measurements across wide parameter spaces to understand physical phenomena. As experiments grow in complexity—with longer measurement times and a greater diversity of instruments—efficient automation has become essential. Measurement automation is evolving beyond simple parameter scans toward informatics-driven, condition-based optimization, paving the way for AI-assisted experimental workflow management. This progress demands robust software infrastructure capable of high integration and flexible logic control.

However, building such a system remains nontrivial for researchers. At the low level, instrument methods tightly coupled to diverse communication protocols (e.g., TCP/IP, VISA, serial, etc.) limit interchangeability and cross-system flexibility. At the high level, coordinating workflows that combine conditional logic, iterative processes, and advanced algorithms across multiple libraries often leads to redundant implementations across contexts, reducing efficiency. Moreover, designing graphical user interfaces (GUIs) for these low- and high-level functionalities typically involves complex multithreading, which requires familiarity with GUI libraries and underlying operating system (OS) event-handling mechanisms. These challenges impose significant substantial development overhead, underscoring the need for a control framework that balances architectural flexibility with reduced implementation complexity.

State of the field

Commercial platforms such as LabVIEW ([National Instruments Corporation, 2024](#)) and MATLAB's Instrument Control Toolbox ([The MathWorks, Inc., 2024](#)) provide mature solutions for

40 instrument communication and measurement execution, but their proprietary environments
41 limit integration with the open-source Python ecosystem and its evolving scientific libraries.
42 Python frameworks including QCoDeS ([Nielsen et al., 2025](#)), PyMeasure ([PyMeasure Developers, 2024](#)),
43 and PyOpticon ([Randall & Majumdar, 2025](#)) offer strong ecosystem compatibility and
44 provide instrument drivers, experiment routines, and GUI components. However, efficient
45 workflow orchestration, particularly for conditional logic, nested procedures, and multithreading,
46 still requires substantial user implementation. Without a dedicated workflow abstraction layer,
47 workflow logic often resides alongside instrument control and GUI code, limiting modular
48 reuse across experiments. Thus, although existing frameworks address specific aspects
49 of instrument control, ecosystem integration, or GUI construction, none unifies hardware
50 abstraction, reusable workflow definition, encapsulated concurrency management, and low-code
51 experiment composition within a single architecture.

To address this gap, lys_instr introduces a layered architecture spanning low-level instrument interfaces to high-level GUI integration. In particular, it defines a dedicated workflow layer that abstracts common measurement patterns from device-specific implementations. By separating instrument control, workflow coordination, and GUI components, lys_instr enables reusable workflows, built-in hidden multithreading, and low-code construction of complex experiments. This architectural shift—rather than incremental extension of existing frameworks—was necessary to achieve extensibility, coding efficiency, and usability within a coherent system.

60 Software design

`lys_instr` adopts a three-layer architecture organized by functional separation (Figure 1). Each layer applies object-oriented design patterns from GoF (Gamma et al., 1994), according to its responsibilities, enhancing flexibility, modularity, and usability.

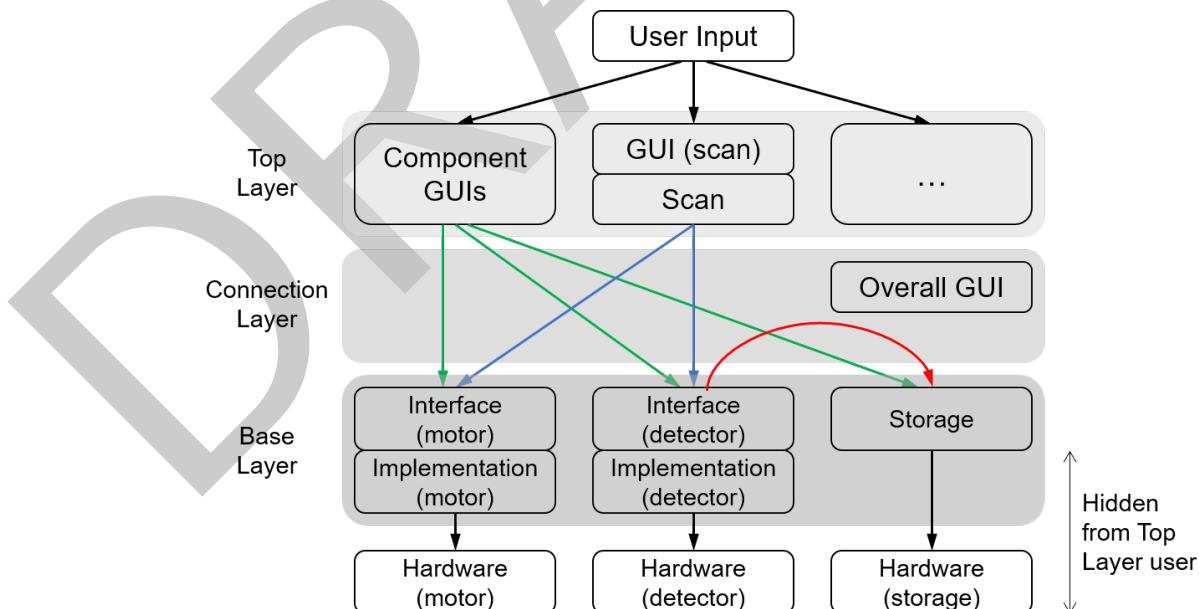


Figure 1: Schematic of the code architecture of lys_instr.

1. Base Layer: Device Controller Abstraction

65 This layer defines abstract interfaces that standardize core instrument controllers. The interfaces
66 encapsulate the concrete implementations, following the *Template Method* design pattern.
67 Typically, most measurement systems include two types of components: *controllers*, which

68 adjust experimental parameters such as external fields, temperature, or physical positions,
69 and *detectors*, which record experimental data, e.g., cameras, spectrometers. Accordingly,
70 `lys_instr` provides standardized *controller* and *detector* interfaces that unify instrument
71 behavior, allowing higher layers to operate on different devices uniformly through common
72 interfaces. Users only need to provide device-specific subclasses that inherit from these
73 interfaces to handle communication with their respective hardware devices. Moreover, each
74 interface manages its own thread(s), ensuring responsiveness and asynchronous operation
75 without blocking other controllers or the GUIs in higher layers. This structure enables users
76 to create controller objects that can be readily integrated into higher-level workflows with
77 minimal device-specific coding.

78 2. Top Layer: Workflow Coordination

79 This layer implements workflows common across many setups. Most measurements share similar
80 procedural structures, such as a *scan* process in which data are sequentially recorded while
81 parameters like fields, temperature, or positions are varied. These workflows are standardized
82 using the abstract interfaces defined in the Base Layer, independent of any specific hardware
83 devices, following the *Bridge* and *Composite* design patterns. For example, `lys_instr` provides
84 a standardized *scan* routine that calls *controller* and *detector* interface methods without
85 requiring knowledge of the underlying concrete implementations. This abstraction allows such
86 workflows to be reused across different hardware configurations, greatly improving coding
87 efficiency. In addition, `lys_instr` includes prebuilt GUI components corresponding to each
88 Base Layer component, enabling direct GUI-based control through the same abstract methods.
89 This design cleanly separates workflow logic from device-specific details, simplifying extension
90 to complex measurement systems. Moreover, the GUI communicates with Base Layer interfaces
91 via event-driven messaging, following the *Observer* design pattern to ensure low coupling
92 and high extensibility. With this layer, users can design measurement workflows from scratch
93 without manually creating GUI components.

94 3. Connection Layer: Control-System Assembly

95 This layer enables flexible assembly of components from the Base and Top Layers into a
96 complete control system by managing connections within and across layers. Following the
97 *Mediator* design pattern, it connects abstract Base Layer interfaces (and the corresponding
98 hardware devices) to enable automatic data flow, and links GUI components to their respective
99 interfaces, fully hiding device-specific implementations from this layer and above. It also
100 organizes the GUI components into a cohesive application for user interaction. This design
101 grants users maximum freedom to construct tailored control systems without handling low-level
102 tasks such as inter-device communication or multi-threading. Several prebuilt GUI templates
103 for common scenarios are provided for quick hands-on use.

104 Overall, `lys_instr` provides prebuilt support for standard device controllers, common
105 experimental workflows, and GUI components and assemblies, so users generally need to
106 implement only device-specific subclasses to handle communication with their hardware. This
107 enables rapid integration of new instruments into automated measurement workflows with
108 minimal coding and design effort.

109 Example of constructed GUI

110 With `lys_instr`, users can easily construct a GUI like the one shown in [Figure 2](#). In this
111 example, the `lys_instr` window is embedded in the `lys` platform, with Sector A for storage,
112 Sector B for detector, and Sector C for controllers. Multi-dimensional, nested scan sequences
113 can be defined via the visual interface in the Scan tab in Sector C. `lys` tools in the outer
114 window tabs allow customization of data display, enabling advanced, on-the-fly customization
115 of data visualization.

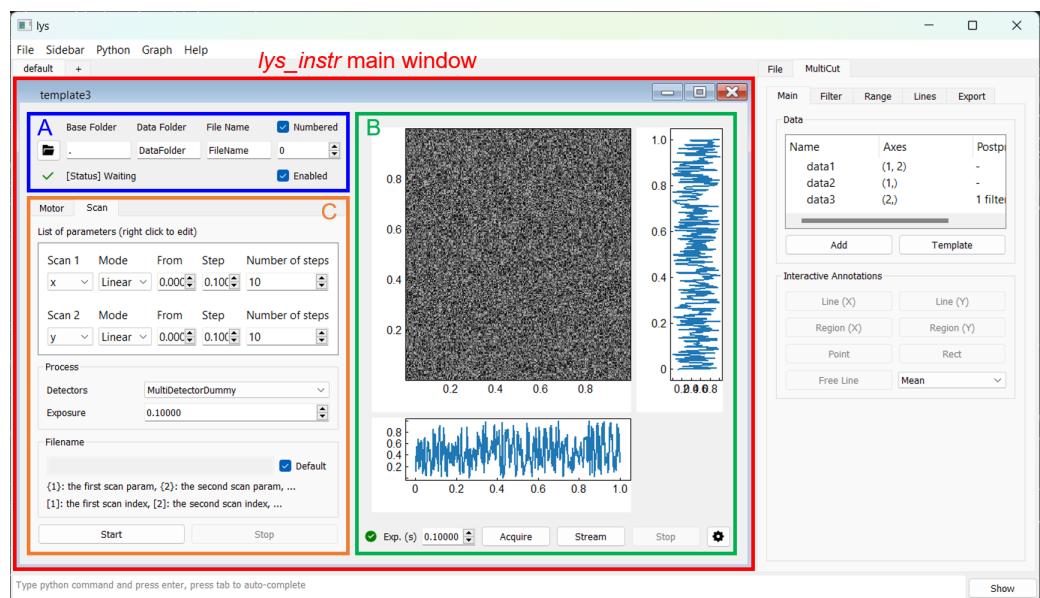


Figure 2: Example GUI of `lys_instr`. The main window, embedded in the `lys` window, contains three sectors: Storage panel (A), Detector panel (B), and controller panel (C). The Scan tab in (C) enables dynamic configuration of multi-dimensional, nested experimental workflows.

116 Research impact statement

117 `lys_instr` has been deployed in complex, real-world scientific experiments and has supported
 118 multiple peer-reviewed publications. It automates ultrafast electron diffraction (UED) and
 119 ultrafast transmission electron microscopy (UTEM) systems, coordinating ultrafast laser
 120 excitation and pulsed electron beam detection in pump–probe experiments (Koga et al., 2024;
 121 Nakamura et al., 2020, 2021, 2022, 2023; Shimojima et al., 2021, 2023a, 2023b). It enables
 122 precise control of electromagnetic lenses and electron deflectors for advanced microscopy
 123 involving electron-beam precession, a capability that would be difficult to implement without
 124 `lys_instr` (Hayashi et al., 2026; Shiratori et al., 2024).

125 The software has demonstrated seamless control of transmission electron microscopes from
 126 multiple manufacturers across different institutes, including RIKEN Center for Emergent Matter
 127 Science and Nagoya University, illustrating reproducible performance and hardware-independent
 128 workflow management. Through integration with sister packages in the `lys` family, including
 129 `lys_em` ([lys_em Developers, 2026](#)) and `lys_fem` ([lys_fem Developers, 2026](#)), `lys_instr`
 130 supports complex multi-instrument automation within a research-driven ecosystem, enabling
 131 efficient deployment of advanced workflows while preserving modularity and extensibility.

132 AI usage disclosure

133 Generative AI tools were used to provide debugging suggestions during the final stages of
 134 software development. All code was implemented, reviewed, and verified on real hardware,
 135 with functionality confirmed through unit tests and experimental validation.

136 Acknowledgements

137 We acknowledge valuable comments from Takahiro Shimojima and Kyoko Ishizaka. This
 138 work was partially supported by Grant-in-Aid for Scientific Research (KAKENHI) Grants
 139 No. 21K13889 and No. 25K00057, and JST PRESTO Grant No. JPMJPR24JA.

140 References

- 141 Gamma, E., Helm, R., Johnson, R., & Vlissides, J. (1994). *Design patterns: Elements of*
142 *reusable object-oriented software*. Addison-Wesley. ISBN: 978-0201633610
- 143 Hayashi, S., Han, D., Tsuji, H., Ishizaka, K., & Nakamura, A. (2026). Development of
144 precession lorentz transmission electron microscopy. *Ultramicroscopy*, 280, 114276. <https://doi.org/10.1016/j.ultramic.2025.114276>
- 145 Koga, J., Chiashi, Y., Nakamura, A., Akiba, T., Takahashi, H., Shimojima, T., Ishiwata,
146 S., & Ishizaka, K. (2024). Unusual photoinduced crystal structure dynamics in TaTe₂
147 with double zigzag chain superstructure. *Applied Physics Express*, 17(4), 042007. <https://doi.org/10.35848/1882-0786/ad3b61>
- 148 lys_em Developers. (2026). *Lys_em: Python package for electron microscopy control and*
149 *data analysis*. https://github.com/a-tock/lys_em
- 150 lys_fem Developers. (2026). *Lys_fem: Python package for finite-element modeling and*
151 *experiment integration*. https://github.com/lys-devel/lys_fem
- 152 Nakamura, A. (2023). lys: Interactive Multi-Dimensional Data Analysis and Visualization
153 Platform. *Journal of Open Source Software*, 8(92), 5869. <https://doi.org/10.21105/joss.05869>
- 154 Nakamura, A., Shimojima, T., Chiashi, Y., Kamitani, M., Sakai, H., Ishiwata, S., Li, H., &
155 Ishizaka, K. (2020). Nanoscale Imaging of Unusual Photoacoustic Waves in Thin Flake
156 VTe₂. *Nano Letters*, 20(7), 4932–4938. <https://doi.org/10.1021/acs.nanolett.0c01006>
- 157 Nakamura, A., Shimojima, T., & Ishizaka, K. (2021). Finite-element Simulation of
158 Photoinduced Strain Dynamics in Silicon Thin Plates. *Structural Dynamics*, 8(2), 024103.
159 <https://doi.org/10.1063/4.0000059>
- 160 Nakamura, A., Shimojima, T., & Ishizaka, K. (2022). Visualizing Optically-Induced Strains
161 by Five-Dimensional Ultrafast Electron Microscopy. *Faraday Discussions*, 237, 27–39.
162 <https://doi.org/10.1039/D2FD00062H>
- 163 Nakamura, A., Shimojima, T., & Ishizaka, K. (2023). Characterizing an Optically Induced
164 Sub-micrometer Gigahertz Acoustic Wave in a Silicon Thin Plate. *Nano Letters*, 23(7),
165 2490–2495. <https://doi.org/10.1021/acs.nanolett.2c03938>
- 166 National Instruments Corporation. (2024). LabVIEW. National Instruments Corporation.
167 <https://www.ni.com/en-us/shop/labview.html>
- 168 Nielsen, J. H., Astafev, M., Nielsen, W. H. P., & others. (2025). QCoDeS: Modular data
169 acquisition framework (Version v0.54.2). <https://doi.org/10.5281/zenodo.17459861>
- 170 PyMeasure Developers. (2024). PyMeasure: Scientific measurement library for instruments,
171 experiments, and live-plotting. (Version 0.14.0). Zenodo. <https://doi.org/10.5281/zenodo.11241567>
- 172 Randall, R., & Majumdar, A. (2025). PyOpticon: An open-source python package for laboratory
173 control, automation, and visualization. *Chemistry of Materials*, 37(13), 4585–4592. <https://doi.org/10.1021/acs.chemmater.5c00644>
- 174 Shimojima, T., Nakamura, A., & Ishizaka, K. (2023a). Development of Five-Dimensional
175 Scanning Transmission Electron Microscopy. *Review of Scientific Instruments*, 94(2),
176 023705. <https://doi.org/10.1063/5.0106517>
- 177 Shimojima, T., Nakamura, A., & Ishizaka, K. (2023b). Development and Applications
178 of Ultrafast Transmission Electron Microscopy. *Microscopy*, 72(4), 287–298. <https://doi.org/10.1093/jmicro/dfad021>

- 185 Shimojima, T., Nakamura, A., Yu, X., Karube, K., Taguchi, Y., Tokura, Y., & Ishizaka, K.
186 (2021). Nano-to-Micro Spatiotemporal Imaging of Magnetic Skyrmion's Life Cycle. *Science
187 Advances*, 7(25), eabg1322. <https://doi.org/10.1126/sciadv.abg1322>
- 188 Shiratori, T., Koga, J., Shimojima, T., Ishizaka, K., & Nakamura, A. (2024). Development of
189 ultrafast four-dimensional precession electron diffraction. *Ultramicroscopy*, 267, 114064.
190 <https://doi.org/10.1016/j.ultramic.2024.114064>
- 191 The MathWorks, Inc. (2024). *MATLAB instrument control toolbox*. The MathWorks, Inc.
192 <https://www.mathworks.com/products/instrument.html>

DRAFT